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MOS FIELD EFFECT TRANSISTOR 2SK2541

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR HIGH SPEED SWITCHING

DESCRIPTION

The 2SK2541 is a switching device which can be driven directly by a 1.5 V power source.

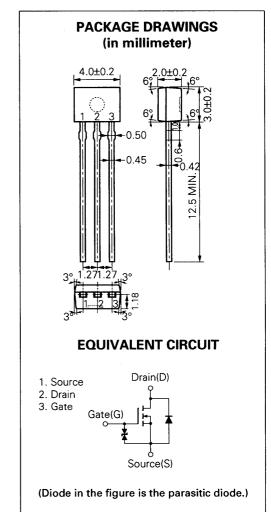
The MOS FET has excellent switching characteristics and is suitable for use as a high-speed switching device in digital circuits.

FEATURES

- Can be driven by a 1.5 V power source.
- Not necessary to consider driving current because of its high input impedance.
- Possible to reduce the number of parts by omitting the bias resistor.

ABSOLUTE MAXIMUM RATINGS (TA = +25 °C)

Drain to Source Voltage	VDSS	50	V
Gate to Source Voltage	Vgss	±7.0	۷
Drain Current (DC)	ID(DC)	±0.1	А
Drain Current (pulse)	D(pulse)	±0.2 *	А
Total Power Dissipation	Рт	250	mW
Channel Temperature	Тсн	150	°C
Storage Temperature	Tstg	-55 to +150	°C
*PW ≦10 ms, Duty cycle ≦ 1 %			



The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device is actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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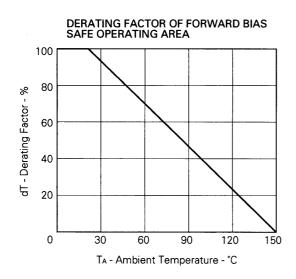
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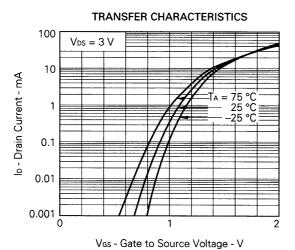
ELECTRICAL CHARACTERISTICS (TA = +25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Drain Cut-off Current	IDSS			1.0	μA	VDS = 50 V, VGS = 0
Gate Leakage Current	lgss			±3.0	μA	$V_{GS} = \pm 7.0 V, V_{DS} = 0$
Gate Cut-off Voltage	VGS(off)	0.5	0.7	1.1	v	Vps = 3.0 V, lp = 1.0 µA
Forward Transfer Admittance	yfs	20			mS	Vps = 3.0 V, lp = 10 mA
Drain to Source On-State Resistance	RDS(on)1		32	50	Ω	VGS = 1.5 V, ID = 1 mA
Drain to Source On-State Resistance	RDS(on)2		16	20	Ω	Vgs = 2.5 V, lp = 10 mA
Drain to Source On-State Resistance	RDS(on)3		12	15	Ω	Vgs = 4.0 V, lp = 10 mA
Input Capacitance	Ciss		6		pF	Vds = 3.0 V, Vgs = 0
Output Capacitance	Coss		8		pF	
Reverse Transfer Capacitance	Crss		1		pF	f = 1.0 MHz
Turn-On Delay Time	td(on)		9		ns	
Rise Time	tr		48		ns	$V_{DD} = 3.0 V, I_{D} = 20 mA$
Turn-Off Delay Time	td(off)		21		ns	$V_{GS(on)} = 3.0 \text{ V}, \text{ Rg} = 10 \Omega$
Fall Time	tr		31		ns	RL = 150 Ω

TYPICAL CHARACTERISTICS (TA = 25 °C)

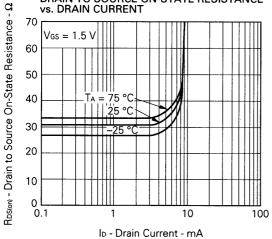
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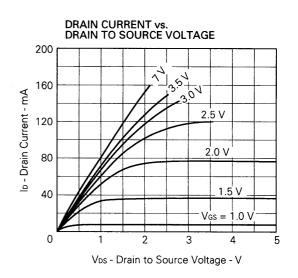




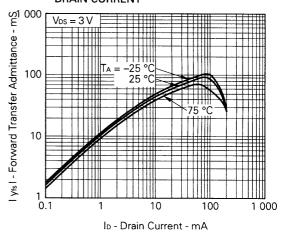
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT Vgs = 1.5 V

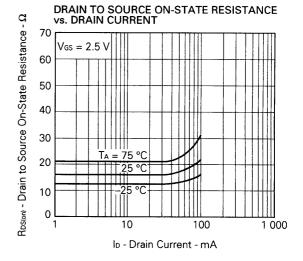
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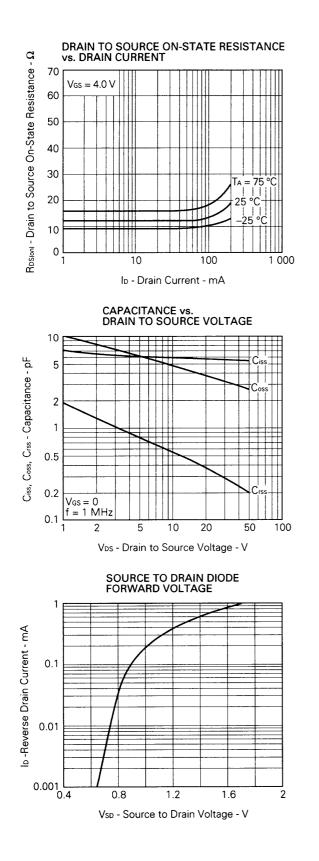


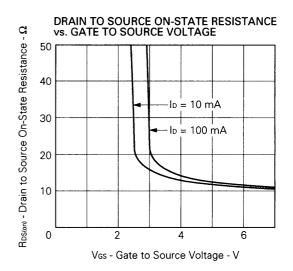


FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

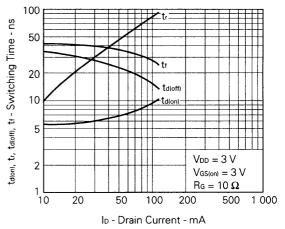








SWITCHING CHARACTERISTICS



REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	TEI-1202		
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	IEI-1207		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	MF-1134		

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- Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.

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